Analyzing Environmental Influences on Corn Yield: A Data-Driven Study in Champaign, Illinois

This manuscript (permalink) was automatically generated from uiceds/project-team-go@aa2b91d on September 27, 2024.

Authors

· Yung Shun Shih

Department of CEE, University of illinois Urbana-Chamapign

Derek Chen

Department of CEE, University of illinois Urbana-Chamapign

• Xinyuan Wang

Department of CEE, University of illinois Urbana-Chamapign

Xiaozhuo Cao [™]

Department of CEE, University of illinois Urbana-Chamapign

Abstract

Bold Project proposal

Environmental factors have a significant impact on agricultural production. For instance, environmental factors including precipitation, humidity, temperature, fertilization, soil, plant disease prevention, as well as pest management would all impact agricultural yield. Therefore, it is very important and interesting to study the impact of environmental factors and their interactions on agricultural yields from previous data.

In this project, a model is proposed to qualitatively describe analyze the impacts from environmental factors on agricultural yield. Data is collected from previous meteorological records and environmental investigations. Specifically, this model analyzes the impact of precipitation, temperature, and soil nutrients on agricultural production, and is able to predict next year's agricultural yield based on given environmental factor values. This model is expected to help decision-makers better plan agricultural production and improve its efficiency.

Bold Data description

The dataset we plan to use is the meteorological records of Champaign, Illinois. We want to predict corn yield by analyzing precipitation and temperature. Data will be obtained from wunderground.com (Savoy, IL Weather History | Weather Underground). And daily temperature and the annual precipitation amount would be needed. The format would be primarily in CSV. The four columns will be temperature (including max, avg and min) and precipitation every day, while the rows will be the date for a whole year.

References